

Notice of References Cited		Application/Control No. 10/662,238	Applicant(s)/Patent Under Reexamination XU ET AL.	
		Examiner Alvin T. Raetzsch	Art Unit 1754	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,835,195	05-1989	Rayfield et al.	523/220
*	B	US-5,000,871	03-1991	Minayoshi et al.	516/33
	C	US-			
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	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
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	M	US-			

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*	N	JP 07097438 A	04-1995	Japan	TANABE et al.	
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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